



Dr. Liam Collins

R&D Staff Scientist

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EDUCATION

Doctor of Philosophy (Physics)	University College Dublin	2015
Masters of Science (Applied Physics)	University of Limerick	2009
Bachelor of Science (Science Education)	University of Limerick	2008

RELEVANT RESEARCH EXPERIENCE

Staff Scientist (R&D Associate) Oak Ridge National Laboratory, Center of Nanophase Materials Sciences, Scanning Probe Microscopy Group	July 2018- Present
Postdoctoral Research Associate Oak Ridge National Laboratory, Center of Nanophase Materials Sciences, Scanning Probe Microscopy Group	2015-July 2018
Graduate Researcher University College Dublin, School of Physics & Conway Institute of Biomolecular and Biomedical Research	2010-2015

SIGNIFICANT AWARDS AND HONORS

CNMS Outstanding Staff Member Award CNMS User Meeting	2020
Significant Event Award Implementation of Interferometric Scanning Probe methods	2020
CNMS Distinguished Patent Award For the development of Electrochemical force microscopy (EcFM)	2018
Postdoctoral Award CNMS Division Awards	2017
R&D 100 Award For development of G-Mode SPM	2016

Microscopy Today Innovation Award	2016
Microscopy Society of America	
MRS Graduate Student Gold Award	2014
Material Research Society (Spring Meeting)	

PATENTS

Invention: Electrochemical Force Microscopy

Inventors: Collins L, Jesse S, Kalinin S K, Rodriguez B J, US Patent 9,541,576.

SELECTED PEER REVIEW PUBLICATIONS

Cumulative Total Number of Articles Published in Peer Reviewed Journals: 64

For full list follow link: [Liam Collins \(Google Scholar Profile\)](#)

Selected Book chapters

- Collins, L.; Somnath, S.; Kalinin, S.V.; Belianinov, A., Scanning probe microscopy in the information age; in *Handbook on Big Data and Machine Learning in the Physical Sciences*; Vol 1, World Scientific, **2020**, 49-99.
- Collins, L.; Weber, S.; Rodriguez, B., Applications of KPFM-based approaches for surface potential and electrochemical measurements in liquid; in *Kelvin probe force microscopy*; 2nd Ed, Springer: New York, **2018**, 49-99.
- Jesse, S.; Collins, L.; Kalinin, S.V., Dynamic Modes in KPFM: Band Excitation and G-Mode; in *Kelvin probe force microscopy - From Single Charge Detection to Device Characterization*; 2nd Ed, Springer: New York, **2018**, 391-433.

Selected Review Articles

- Collins, L.; Kilpatrick, J.; Kalinin, S. V.; Rodriguez, B. J., Nanoscale Electrical Measurements in Liquids Using AFM-Progress and Outlook. *Rep. Prog. Phys.*, **2018**, 81 (8), 086101.

Selected Journal Articles

- Collins, L.; Celano, U., "Revealing Antiferroelectric Switching and Ferroelectric Wakeup in Hafnia by Advanced Piezoresponse Force Microscopy." *ACS Appl. Mater. & Interfaces*, **2020** (in press).
- Collins, L.; Vasudevan, R. K.; & Sehirlioglu, A. Visualizing Charge Transport and Nanoscale Electrochemistry by Hyperspectral Kelvin Probe Force Microscopy. *ACS Appl. Mater. & Interfaces*, **2020**, 12(29), 33361-33369.
- Collins, L.; Liu, Y.; Ovchinnikova, O.S.; and Proksch, R., Quantitative electromechanical atomic force microscopy. *ACS nano*, **2019**, 13(7), pp.8055-8066.
- Collins, L.; Ahmadi, M.; Qin, J.; Liu, Y.; Ovchinnikova, O. S.; Hu, B., ... & Kalinin, S. V., Time resolved surface photovoltage measurements using a big data capture approach to KPFM. *Nanotechnology*, **2018**, 29 (44), 445703.
- Liu, Y.; Collins, L.; Proksch, R.; Kim, S.; Watson, B. R.; Doughty, B., ... & Ovchinnikova, O., Chemical nature of ferroelastic twin domains in CH₃N₃Pb₃ perovskite. *Nat. Mat.*, **2018**, 17 (11), 1013.

- Ahmadi, M.; Collins, L.; Puretzky, A.; Zhang, J.; Keum, J. K.; Lu, W.; Ivanov, I.; Kalinin, S.V.; and Hu, B., Exploring anomalous polarization dynamics in organometallic halide perovskites. *Adv. Mat.*, **2018**, *30* (11), 1705298.
- Shi, Y.; Collins, L.; Balke, N.; Liaw, P. K.; and Yang, B., In-situ electrochemical-AFM study of localized corrosion of Al_xCoCrFeNi high-entropy alloys in chloride solution. *App. Surf. Sci.*, **2018**, *439*, 533-544.
- Collins, L.; Ahmadi, M.; Wu, T.; Hu, B.; Kalinin, S. V.; Jesse, S., Breaking the Time Barrier in Kelvin Probe Force Microscopy: Fast Free Force Reconstruction Using the G-Mode Platform. *ACS Nano*, **2017**, *11* (9), 8717-8729.
- Wu, T.; Collins, L.; Zhang, J.; Lin, P.-Y.; Ahmadi, M.; Jesse, S.; Hu, B., Photoinduced Bulk Polarization and Its Effects on Photovoltaic Actions in Perovskite Solar Cells. *ACS Nano*, **2017**, *11* (11), 11542-11549.
- Collins, L.; Belianinov, A.; Somnath, S.; Rodriguez, B. J.; Balke, N.; Kalinin, S. V.; Jesse, S., Multifrequency Spectrum Analysis Using Fully Digital G Mode-Kelvin Probe Force Microscopy. *Nanotechnology*, **2016**, *27*, 105706.
- Collins, L.; Belianinov, A.; Somnath, S.; Balke, N.; Kalinin, S. V.; Jesse, S., Full Data Acquisition in Kelvin Probe Force Microscopy: Mapping Dynamic Electric Phenomena in Real Space. *Sci. Rep.*, **2016**, *6*, 30557.
- Collins, L.; Okatan, M.; Li, Q.; Kravchenko, I.; Lavrik, N.; Kalinin, S.; Rodriguez, B.; Jesse, S., Quantitative 3D-Kpfm Imaging with Simultaneous Electrostatic Force and Force Gradient Detection. *Nanotechnology*, **2015**, *26*, 175707.
- Collins, L.; Jesse, S.; Kilpatrick, J. I.; Tselev, A.; Okatan, M. B.; Kalinin, S. V.; Rodriguez, B. J., Kelvin Probe Force Microscopy in Liquid Using Electrochemical Force Microscopy. *Beilstein J. Nanotechnol.*, **2015**, *6*, 201.
- Collins, L.; Jesse, S.; Balke, N.; Rodriguez, B. J.; Kalinin, S.; Li, Q., Band Excitation Kelvin Probe Force Microscopy Utilizing Photothermal Excitation. *App. Phy. Lett.*, **2015**, *106*, 104102.
- Collins, L.; Kilpatrick, J. I.; Vlassiouk, I. V.; Tselev, A.; Weber, S. A.; Jesse, S.; Kalinin, S. V.; Rodriguez, B. J., Dual Harmonic Kelvin Probe Force Microscopy at the Graphene-Liquid Interface. *App. Phy. Lett.*, **2014**, *104*, 133103.
- Collins, L.; Jesse, S.; Kilpatrick, J. I.; Tselev, A.; Varenyk, O.; Okatan, M. B.; Weber, S. A.; Kumar, A.; Balke, N.; Kalinin, S. V., Probing Charge Screening Dynamics and Electrochemical Processes at the Solid–Liquid Interface with Electrochemical Force Microscopy. *Nat. Comm.*, **2014**, *5*, 3871.
- Collins, L.; Kilpatrick, J.; Weber, S. A.; Tselev, A.; Vlassiouk, I. V.; Ivanov, I. N.; Jesse, S.; Kalinin, S.; Rodriguez, B., Open Loop Kelvin Probe Force Microscopy with Single and Multi-Frequency Excitation. *Nanotechnology*, **2013**, *24*, 475702.

SELECTED ORAL PRESENTATIONS

Invited

- International Conference on Scanning Probe Microscopy on Soft and Polymeric Materials (SPMonSPM), August 2018, Leuven, Belgium. *Title: "Probing Ultrafast charge dynamics using G-Mode KPFM".*

- 231st Electrochemical Society (ECS) biannual meeting , May 2017, New Orleans, USA. *Title: "Probing Local Electrochemical Functionalities at Solid-Liquid Interfaces".*

Contributed

- Materials Research Society, Dec 2017, Boston, MA, USA. *Title: "Breaking the Time Barrier in Kelvin Probe Force Microscopy".*
- Materials Research Society, Dec 2017, Boston, MA, USA. *Title: "Electrochemical Force microscopy: Nanoscale force based electrochemical measurements in-situ".*
- Tech Connect, Dec 2017, Ann Harbour, VA, USA. *Title: "Bringing Kelvin probe force microscopy into the information age".*
- 5th Multifrequency AFM, June 2014, Madrid, Spain. *Title: "Electrochemical force microscopy: Probing local charge screening, ion diffusion, and electrochemical processes at the solid-liquid interface".*
- Materials Research Society, April 2014, San Francisco, Ca, USA. *Title: "Electrochemical force microscopy: Probing local charge screening, ion diffusion, and electrochemical processes at the solid-liquid interface". (Recipient of Gold MRS Graduate Student award.)*
- Materials Research Society, Dec 2013, Boston, MA, USA. *Title: "Force volume band excitation KPFM: Combined amplitude and frequency modulated KPFM".*
- Materials Research Society, Dec 2013, Boston, MA, USA. *Title: "Realizing Kelvin Probe Force Microscopy in Liquid Environments through Multidimensional Spectroscopic Imaging".*
- 3rd Multifrequency AFM, March 2011, Madrid, Spain. *Title: "Open loop-Kelvin Probe force microscopy techniques in the single and multi-frequency domains".*
- Materials Research Society, Dec 2011, Boston, MA, USA. *Title: "Dual harmonic-Kelvin probe force microscopy for characterization of surface potentials".*
- 24th European Conference on Biomaterials, June 2011, Dublin, Ireland. *Title: "Nanoscale electrostatic characterization of biomaterials".*